QPA1013D

6 – 18GHz 10W GaN Power Amplifier

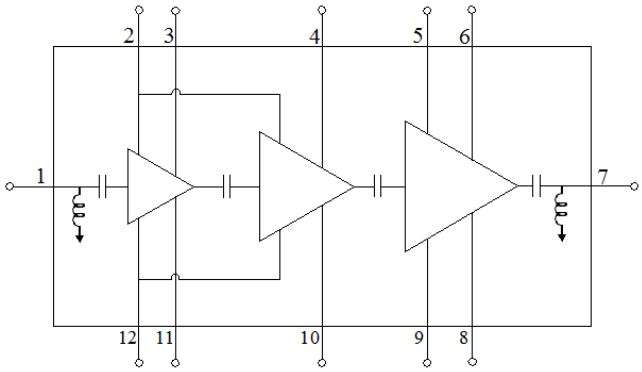
Applications

- Test Instrumentation
- Electronic Warfare (EW)
- Radar
- Communications

Product Features

- Frequency Range: 6 – 18GHz
- P_{OUT}: >40dBm @ P_{IN} = 20dBm
- PAE: >20% @ P_{IN} = 20dBm
- Large Signal Gain: >20dB @ P_{IN} = 20dBm
- Small Signal Gain: >25dB
- Return Loss: >6.5dB
- Bias: V_D = 20V, I_{DQ} = 1250mA, V_G = -2.4V Typical
- Chip Dimensions: 5.05 x 3.55 x 0.10 mm

Functional Block Diagram



General Description

Qorvo's QPA1013D is a broadband high power MMIC amplifier fabricated on Qorvo's production 0.15um GaN on SiC process (QGAN15). The QPA1013D operates from 6 – 18GHz and provides more than 10W saturated output power with power-added efficiency >20% and large-signal gain >20 dB. This combination of wideband performance provides the flexibility designers are looking for to improve system performance while reducing size and cost.

The QPA1013D is matched to 50Ω with integrated DC blocking capacitors on both RF I/O ports simplifying system integration. The broadband performance makes it ideally suited in support of test instrumentation and electronic warfare, as well as, supporting multiple radar and communication bands.

The QPA1013D is 100% DC and RF tested on-wafer to ensure compliance to electrical specifications.

Lead-free and RoHS compliant.
Evaluation boards are available upon request.

Pad Configuration

Pad No.	Symbol
1	RF In
2, 12	V_{G12}
3, 11	V_{D1}
4, 10	V_{D2}
5, 9	V_{G3}
6, 8	V_{D3}
7	RF Out

Ordering Information

Part	ECCN	Description
QPA1013D	3A001.b.2.c	6 – 18GHz 10W GaN Power Amplifier

Absolute Maximum Ratings

Parameter	Value
Drain Voltage (V_D)	29.5V
Gate Voltage Range (V_G)	-8 to 0V
Drain Current (I_{D1})	480mA
Drain Current (I_{D2})	720mA
Drain Current (I_{D3})	2880mA
Gate Currents (I_{G1}/I_{G2}/I_{G3})	See plot on page 3
Power Dissipation (P_{DISS}), 85°C, CW	75W
Input Power (P_{IN}), 50Ω, V_D = 20V, I_{DQ} = 1250 mA, 85°C, CW	28dBm
Input Power (P_{IN}), VSWR 3:1, V_D = 20V, I_{DQ} = 1250 mA, 85°C, CW	28dBm
Channel Temperature (T_{CH})	275°C
Mounting Temperature (30 seconds)	320°C
Storage Temperature	-55 to 150°C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

Parameter	Value
Drain Voltage (V_D)	20V
Drain Current (I_{DQ})	1250mA (Total)
Gate Voltage (V_G)	-2.4V (Typ.)

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

Test conditions unless otherwise noted: 25°C , V_D = 20V, I_{DQ} = 1250mA, V_G = -2.4V Typical

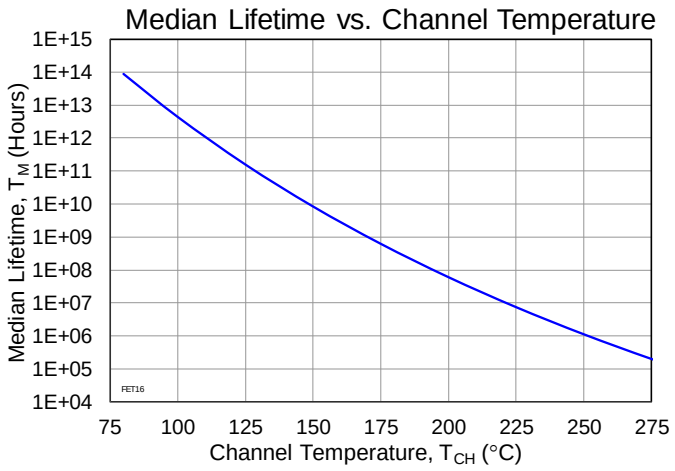
Parameter	Min	Typical	Max	Units
Operational Frequency Range	6		18	GHz
Small Signal Gain		>25		dB
Input Return Loss		>6.5		dB
Output Return Loss		>7		dB
Power Gain (Pin = 20dBm)		>20		dB
Output Power (Pin = 20dBm)		>40		dBm
Power Added Efficiency (Pin = 20dBm)		22		%
Small Signal Gain Temperature Coefficient		-0.061		dB/°C
Output Power Temperature Coefficient (Calculated from 25°C to 85°C) (Pin = 20dBm)		-0.017		dBm/°C

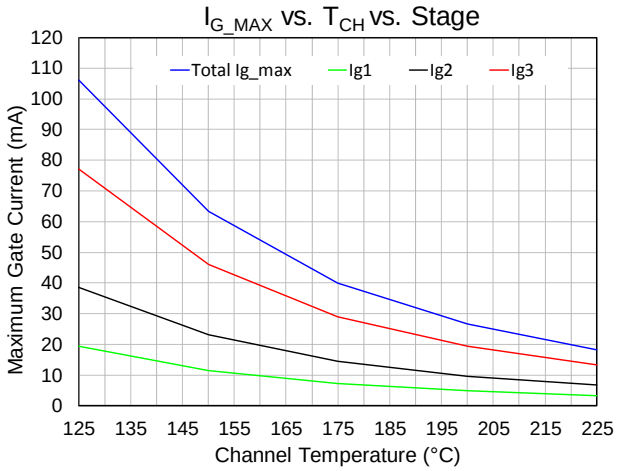
Thermal and Reliability Information

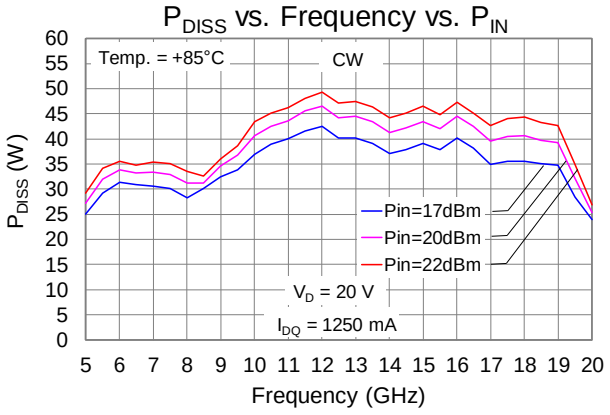
Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC}) (1)	T_{base} = 85°C, CW V_D = 20V, I_{DQ} = 1250mA P_{DISS} = 25W	2.48	ºC/W
Channel Temperature (T_{CH}) (No RF drive)		147	°C
Median Lifetime (T_M)		1.2 x 10^10	Hrs
Thermal Resistance (θ_{JC}) (1)	T_{base} = 85°C, V_D = 20V, I_{DQ} = 1250mA, CW $I_{D\ Drive}$ = 3.3A, Freq = 12GHz P_{IN} = 22dBm, P_{OUT} = 42dBm, P_{DISS} = 49W	2.99	ºC/W
Channel Temperature (T_{CH}) (Under RF drive)		231	°C
Median Lifetime (T_M)		4.7 x 10^6	Hrs

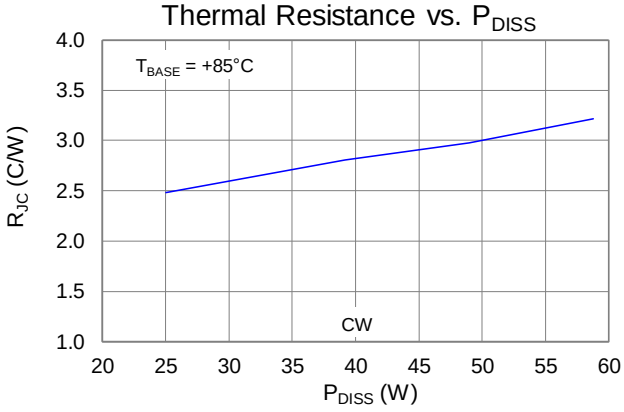
Notes:
1. Thermal resistance measured to back of carrier plate. MMIC mounted on 40 mils CuMo (80/20) carrier using 3 mil AuSn.

Test Conditions: V_D = 28 V; Failure Criteria = 10% reduction in I_{D_MAX}

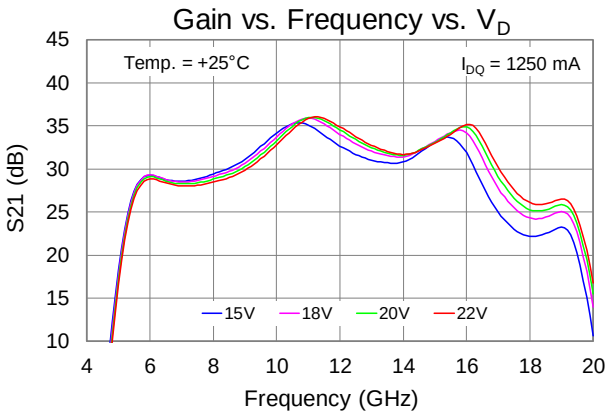


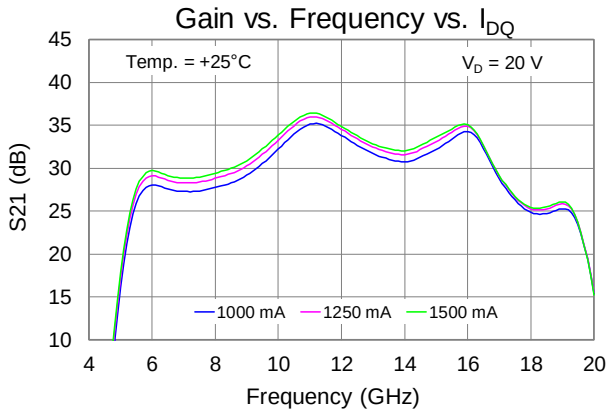


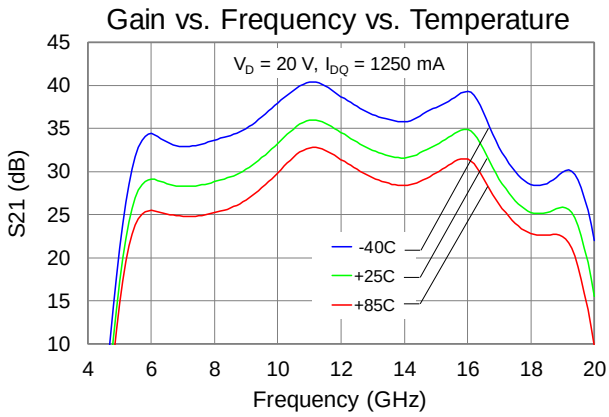


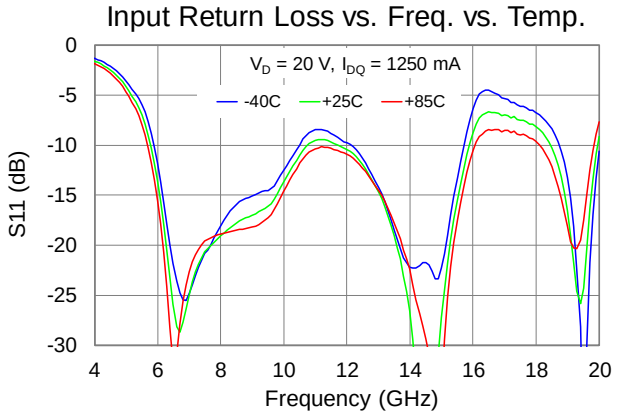


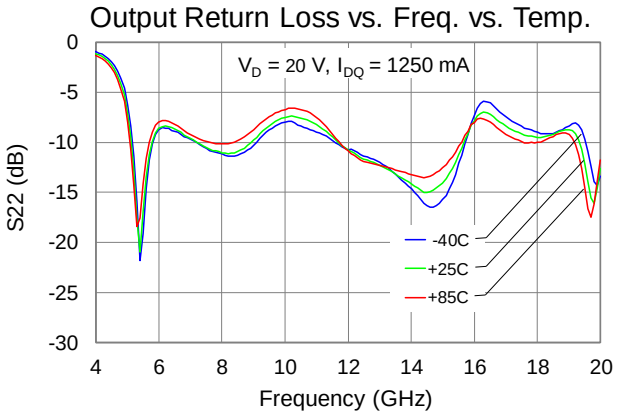
Typical Performance (Small Signal)



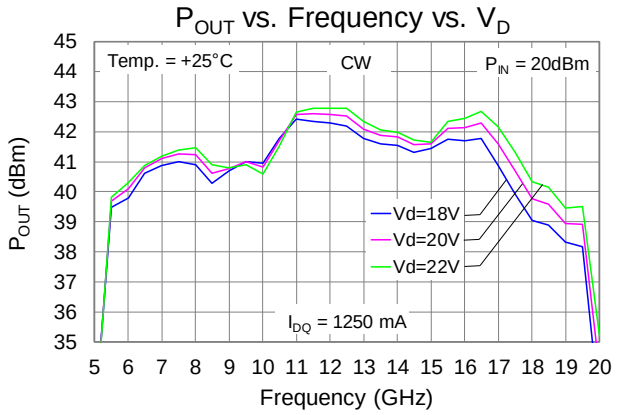


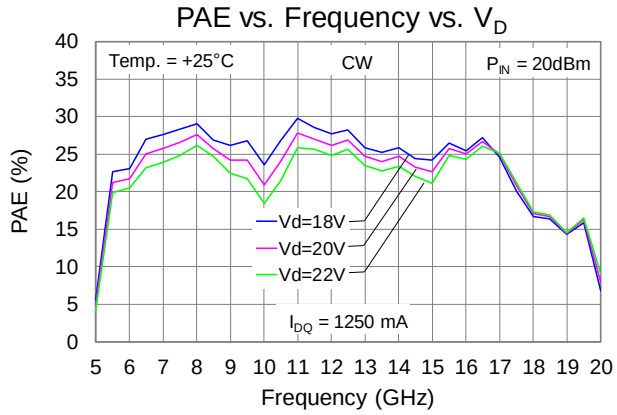


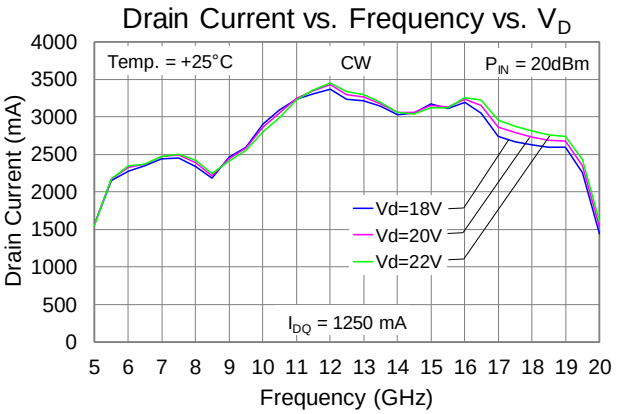


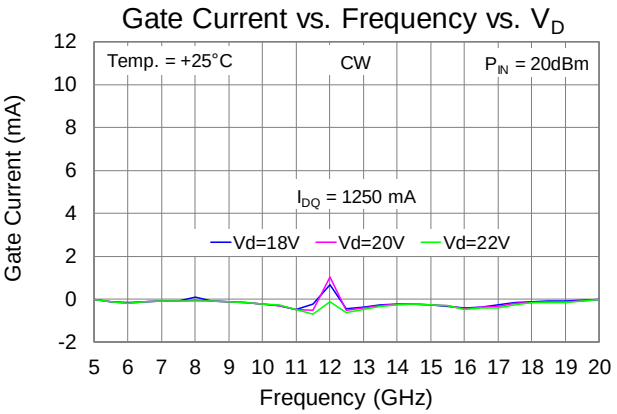


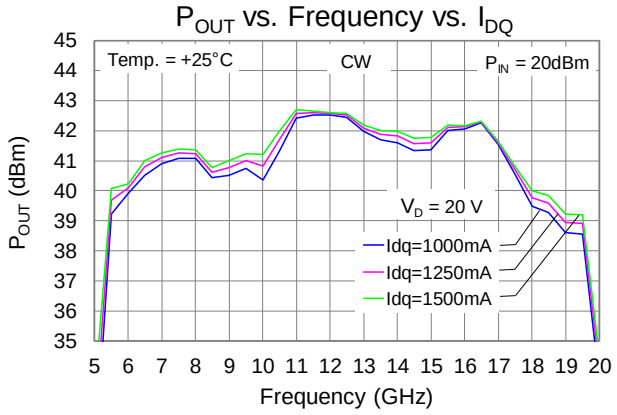
Typical Performance (CW)

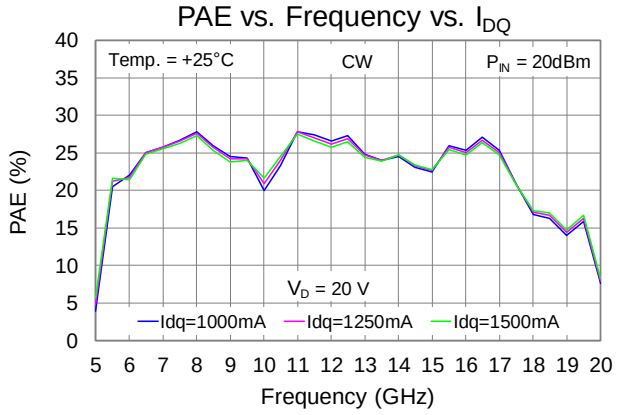






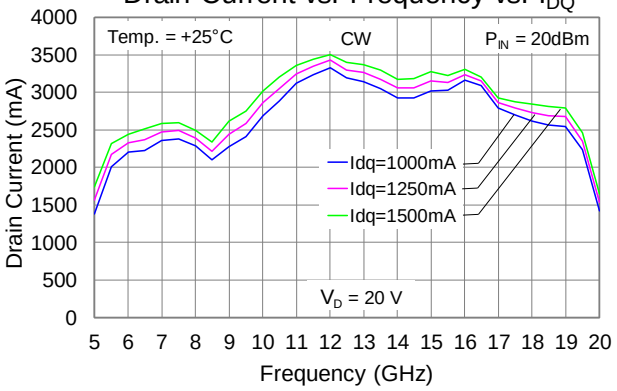




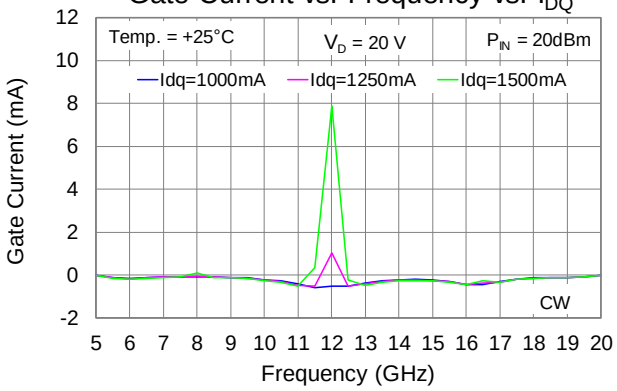


Typical Performance (CW)

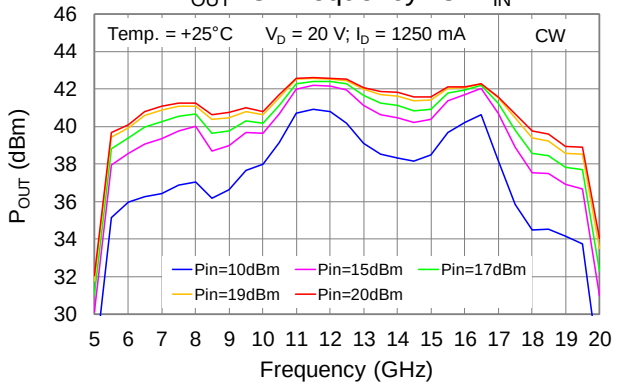
Drain Current vs. Frequency vs. I_{DQ}



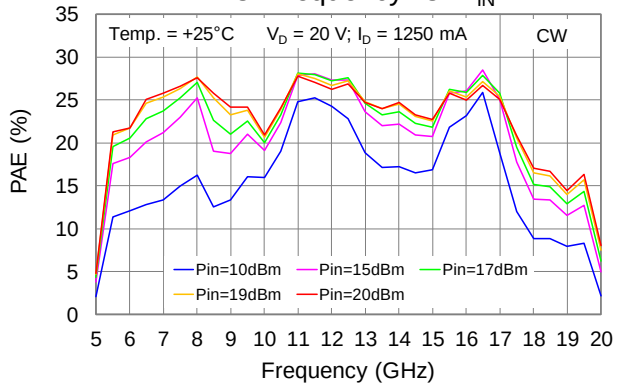
Gate Current vs. Frequency vs. I_{DQ}



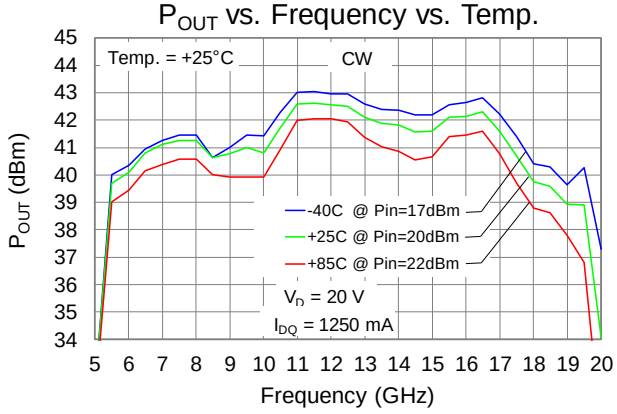
P_{OUT} vs. Frequency vs. P_{IN}.



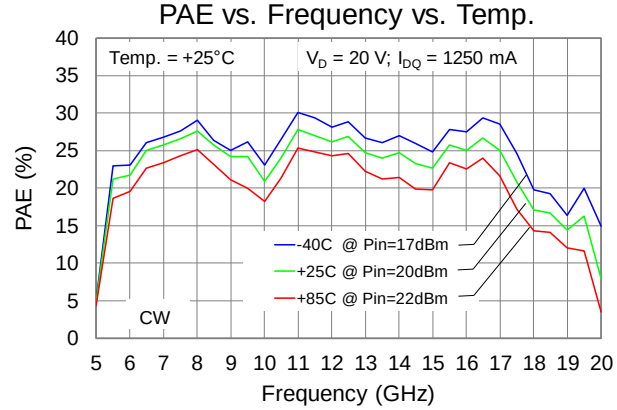
PAE vs. Frequency vs. P_{IN}.



P_{OUT} vs. Frequency vs. Temp.

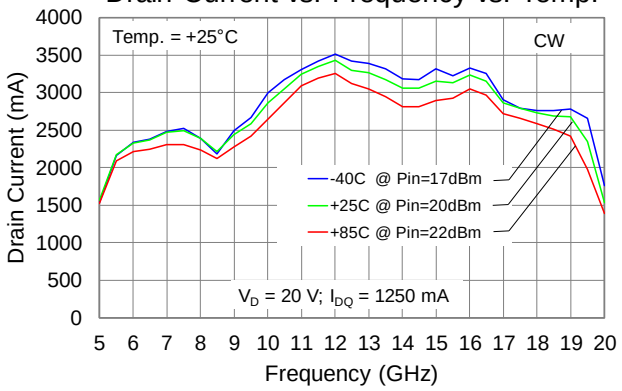


PAE vs. Frequency vs. Temp.

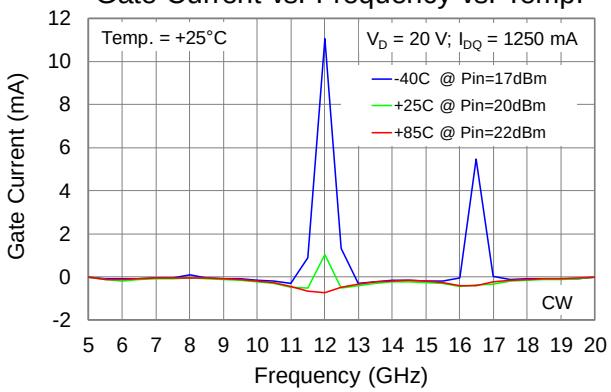


Typical Performance (CW)

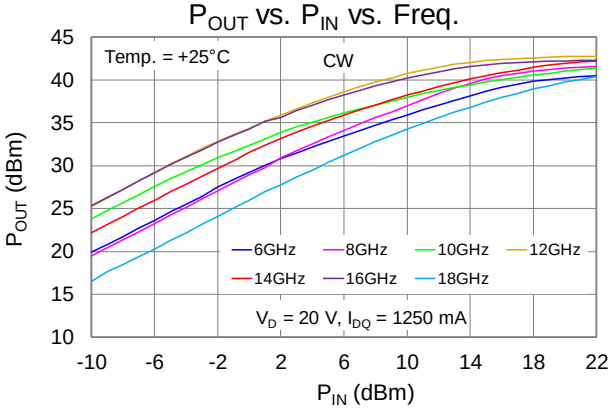
Drain Current vs. Frequency vs. Temp.



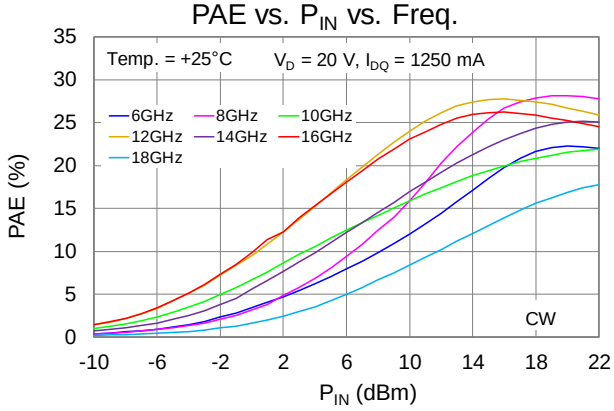
Gate Current vs. Frequency vs. Temp.



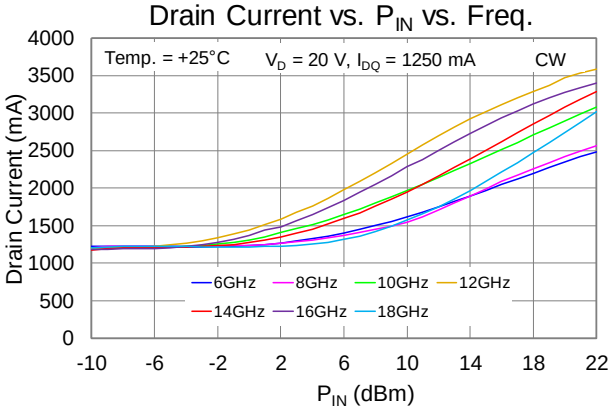
P_{OUT} vs. P_{IN} vs. Freq.



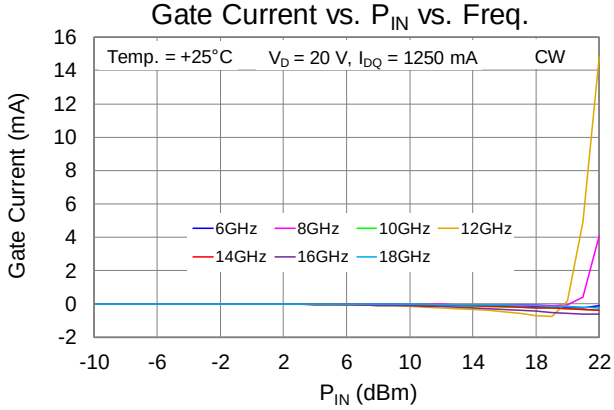
PAE vs. P_{IN} vs. Freq.



Drain Current vs. P_{IN} vs. Freq.

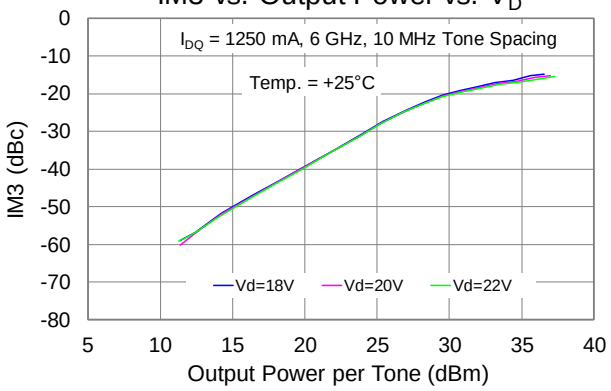


Gate Current vs. P_{IN} vs. Freq.

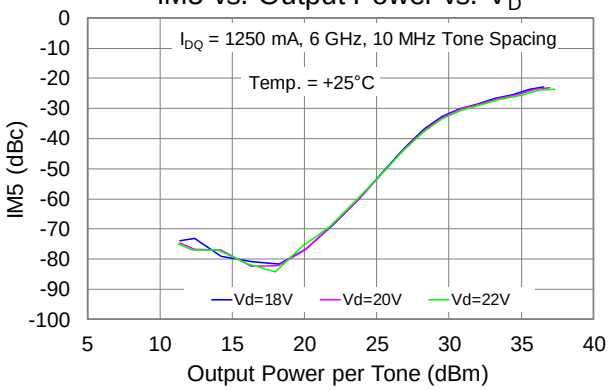


Typical Performance (Linearity)

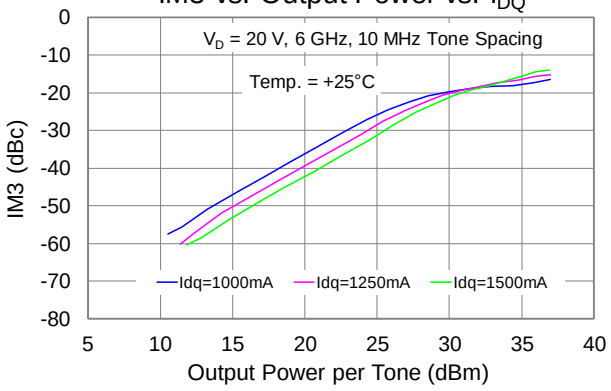
IM3 vs. Output Power vs. V_D



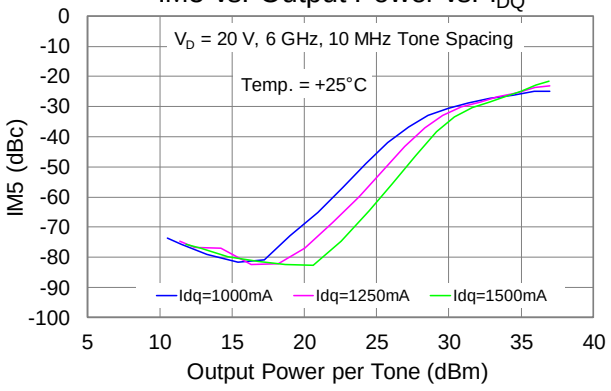
IM5 vs. Output Power vs. V_D



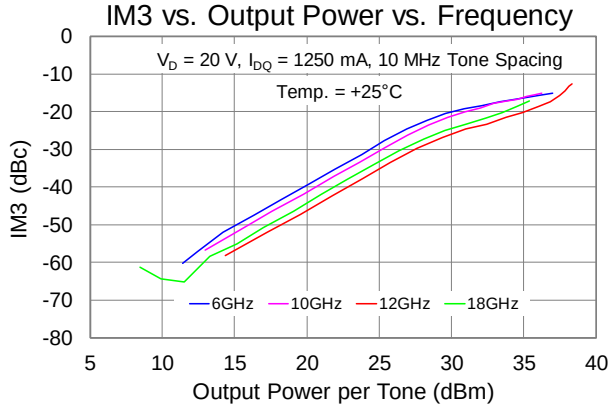
IM3 vs. Output Power vs. I_{DQ}



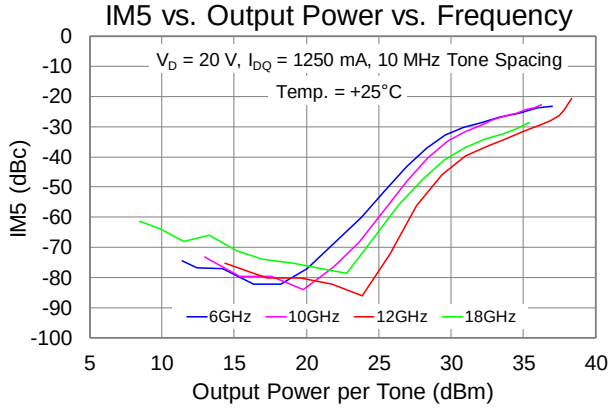
IM5 vs. Output Power vs. I_{DQ}



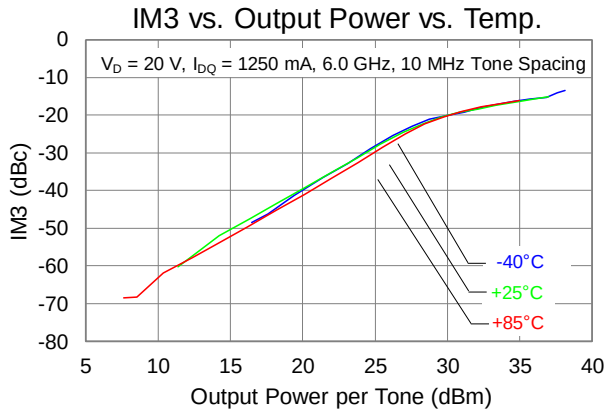
IM3 vs. Output Power vs. Frequency

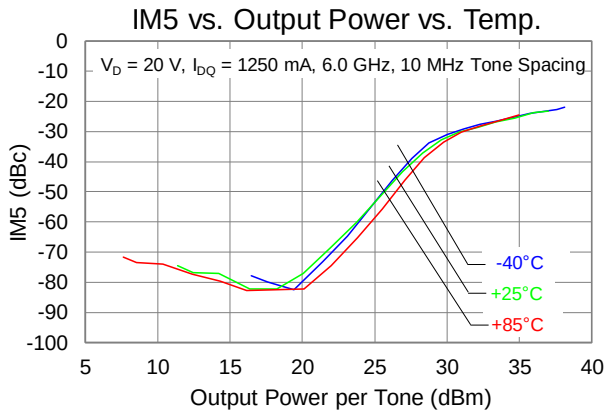


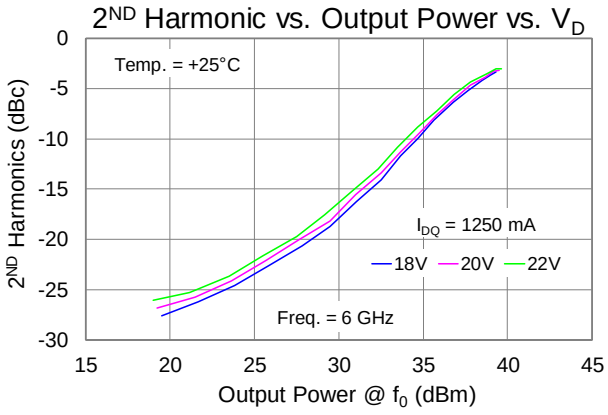
IM5 vs. Output Power vs. Frequency

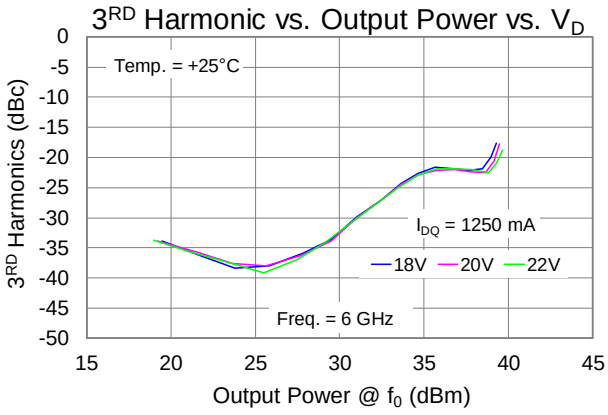


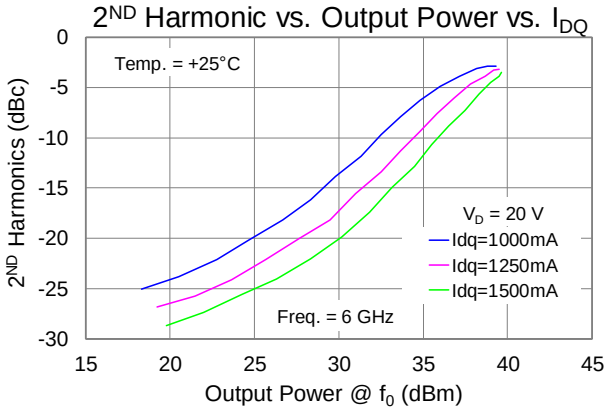
Typical Performance (Linearity)

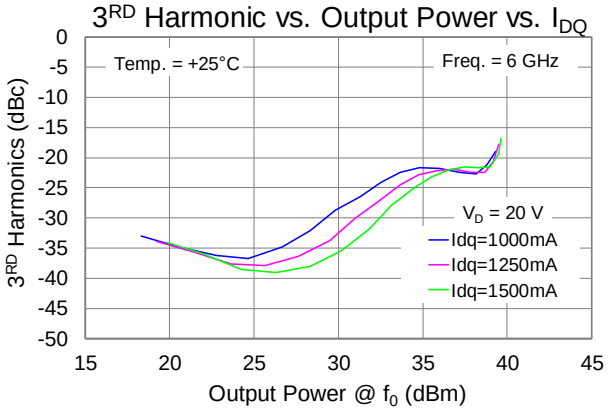






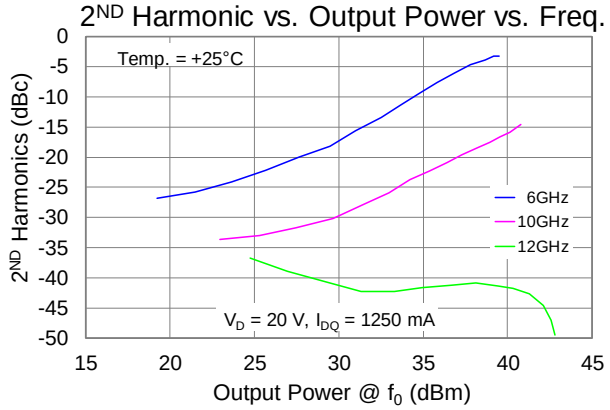




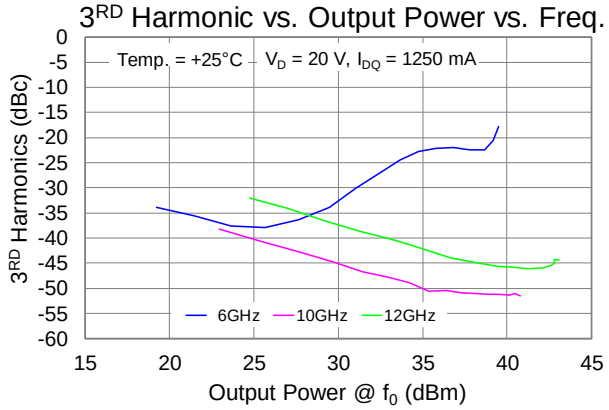


Typical Performance (Linearity)

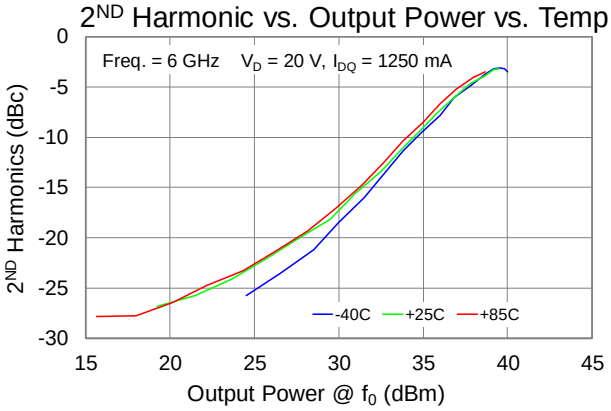
2ND Harmonic vs. Output Power vs. Freq.



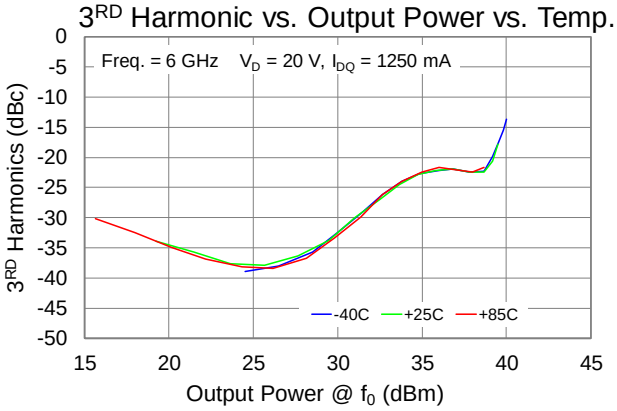
3RD Harmonic vs. Output Power vs. Freq.



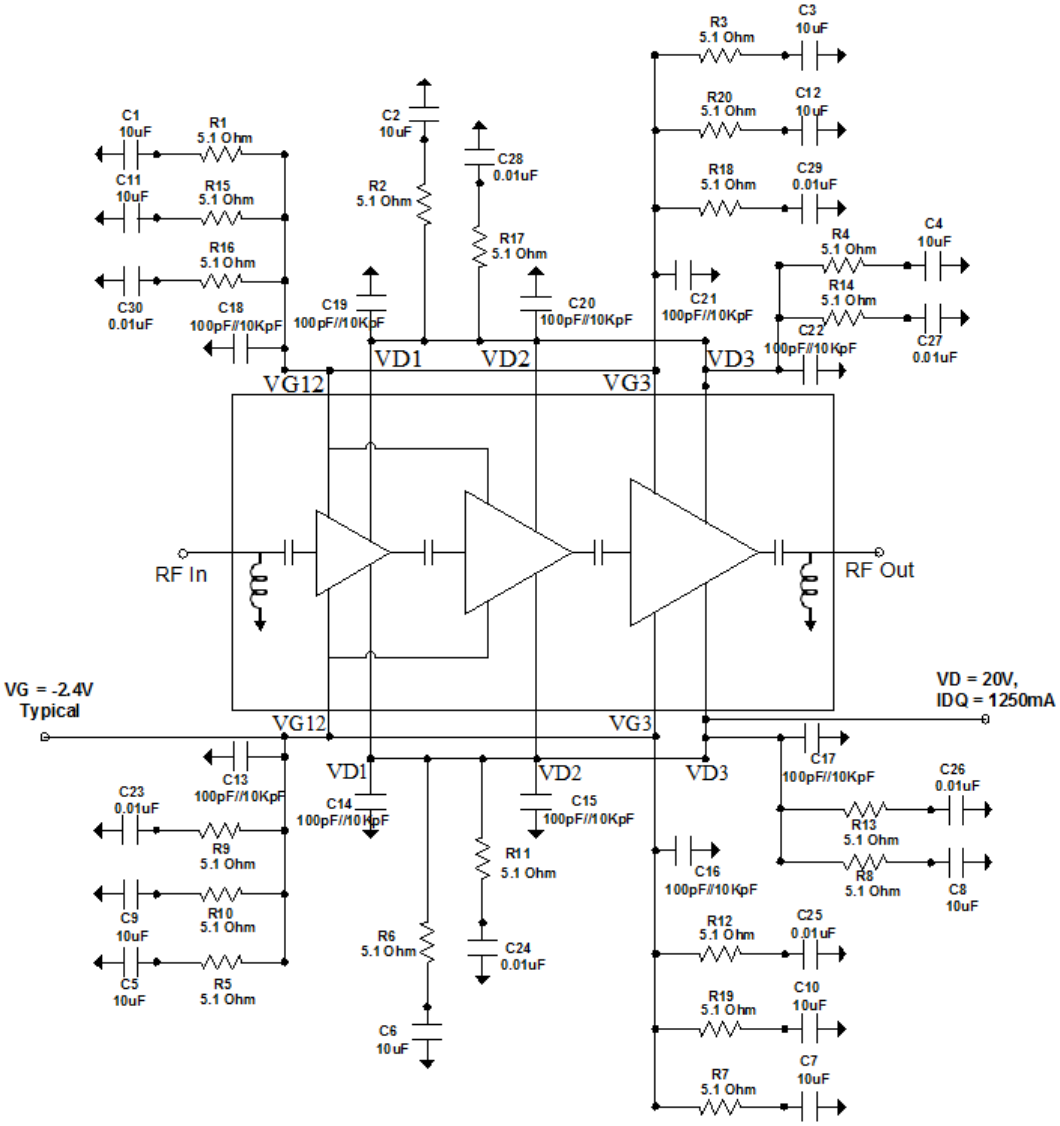
2ND Harmonic vs. Output Power vs. Temp.



3RD Harmonic vs. Output Power vs. Temp.



Application Circuit



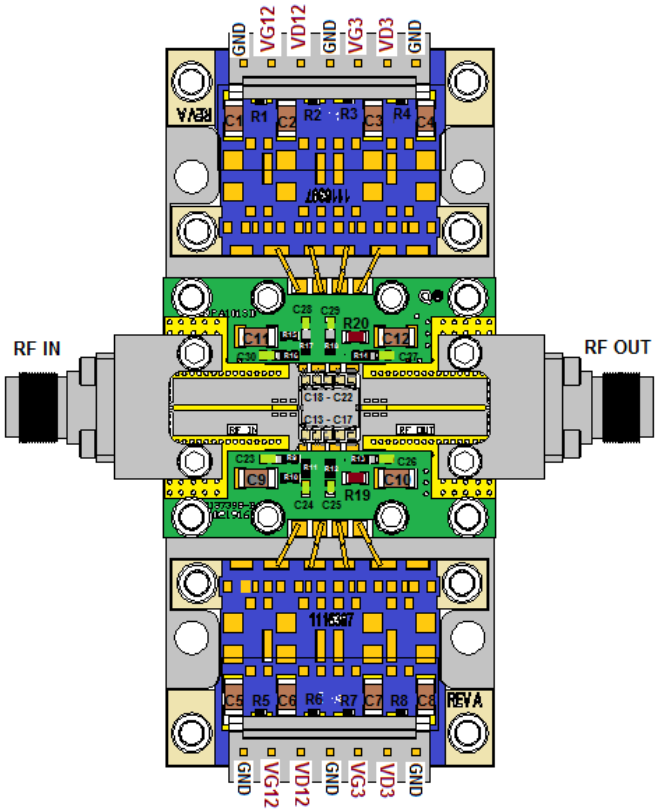
Bias-up Procedure

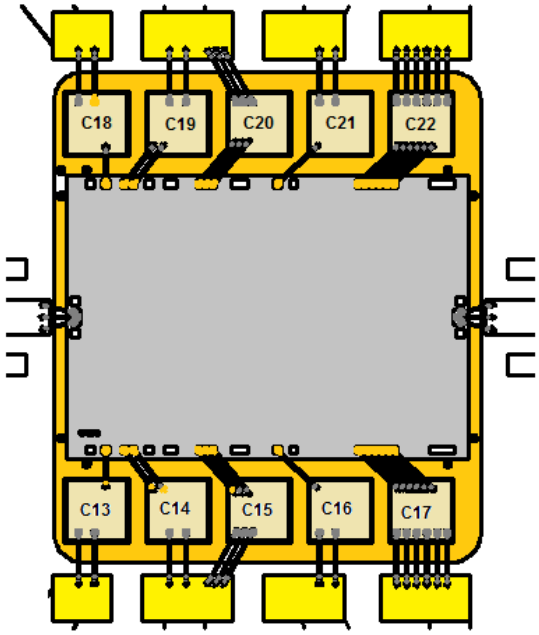
1. Set I_D limit to 4A, I_G limit to 16mA
2. Set V_G to -5.0V
3. Set V_D +20V
4. Adjust V_G more positive until I_{DQ} = 1250mA (V_G ~ -2.4V Typical)
5. Apply RF signal

Bias-down Procedure

1. Turn off RF signal
2. Reduce V_G to -5.0V. Ensure I_{DQ} ~ 0mA
3. Set V_D to 0V
4. Turn off V_D supply
5. Turn off V_G supply

Evaluation Board (EVB) Layout Assembly





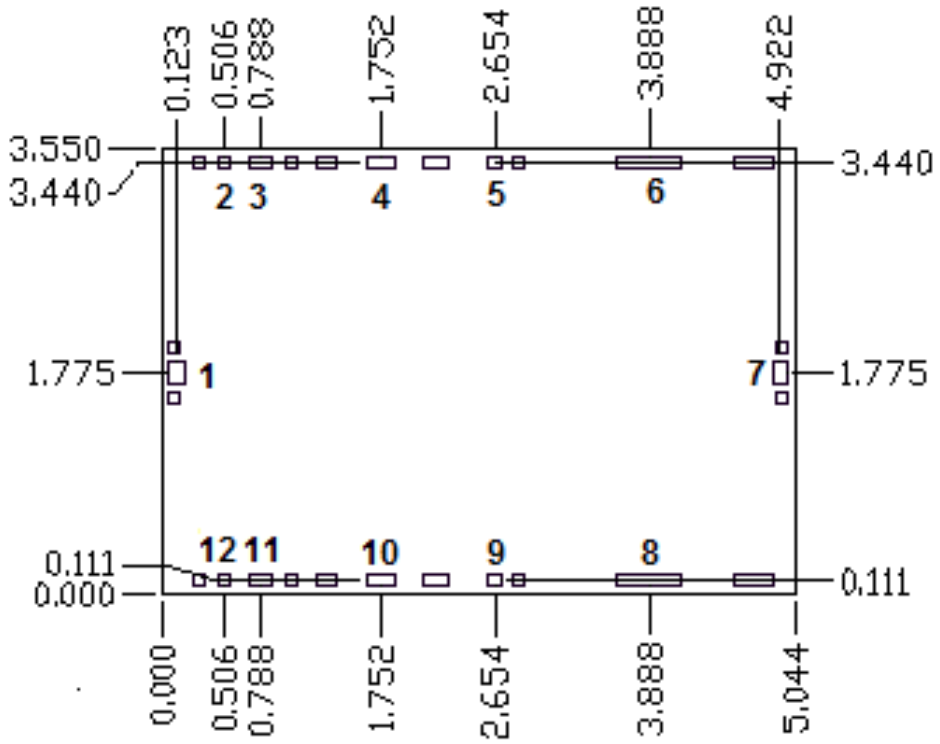
MMIC mounting/wire bonding detail

Notes: The MMIC can be biased from either top or bottom side.

Bill of Materials

Reference Design	Value	Description	Manufacturer	Part Number
C1 – C12	10uF	Cap, 1206, 50V, 20%, X5R	Various	
C13 – C22	100pF//10KpF	Cap, 30x30, 50V, Single Layer	Various	
C23 – C30	0.01uF	Cap, 0402, 50V, 10%, X7R	Various	
R1 – R18	5.1Ω	Res, 0402, 50V, 5%, SMT	Various	
R19 – R20	5.1Ω	Res, 0603, 1%	Various	

Mechanical Drawing & Bond Pad Description



Unit: millimeters
Thickness: 0.10
Die x, y size tolerance: +/- 0.050
Chip edge to bond pad dimensions are shown to center of pad
Ground is backside of die

Bond Pad	Symbol	Pad Size	Description
1	RF In	0.115 x 0.190	RF Input; matched to 50Ω; DC shorted to ground
2, 12	V_{G12}	0.090 x 0.090	Gate voltage 1-2, bias network is required; see Application Circuit on page 11 as an example.
3, 11	V_{D1}	0.190 x 0.090	Drain voltage 1, bias network is required; see Application Circuit on page 11 as an example
4, 10	V_{D2}	0.235 x 0.090	Drain voltage 2, bias network is required; see Application Circuit on page 11 as an example.
5, 9	V_{G3}	0.090 x 0.090	Gate voltage 3, bias network is required; see Application Circuit on page 11 as an example.
6, 8	V_{D3}	0.508 x 0.090	Drain voltage 3, bias network is required; see Application Circuit on page 11 as an example.
7	RF Out	0.115 x 0.190	RF Output; matched to 50Ω; DC shorted to ground

Assembly Notes

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.
- Organic attachment (i.e. epoxy) can be used in low-power applications.
- Curing should be done in a convection oven; proper exhaust is a safety concern.

Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300°C to 3-4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonic are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

Product Compliance Information

ESD Sensitivity Ratings

Caution! ESD-Sensitive Device

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

ECCN

US Department of Commerce: 3A001.b.2.c

Solderability

Use AuSn (80/20) solder and limit exposure to temperatures above 300°C to 3-4 minutes, maximum.

RoHS Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

Contact Information

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